

FDD6680A

N-Channel, Logic Level, PowerTrench® MOSFET

General Description

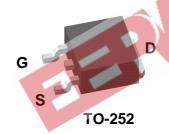
This N-Channel Logic level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

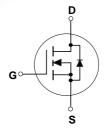
Applications

- DC/DC converter
- Motor drives

Features

- 56 A, 30 V. $R_{DS(ON)} = 0.0095 \Omega @ V_{GS} = 10 V$ $R_{DS(ON)} = 0.0130 \Omega @ V_{GS} = 4.5 V.$
- Low gate charge (23nC typical).
- Fast switching speed.
- High performance trench technology for extremely low R_{DS/ONI}.





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Maximum Drain Current - Continuous	(Note 1)	56	А
		(Note 1a)	14	
	Maximum Drain Current - Pulsed		100	
P _D	Maximum Power Dissipation @ T _C = 25°C	(Note 1)	60	W
	$T_A = 25^{\circ}C$	(Note 1a)	2.8	
	$T_A = 25^{\circ}C$	(Note 1b)	1.3	
T_J , T_{stg}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	2.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	96	°C/W

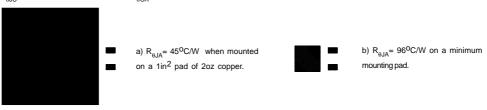
Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDD6680A	FDD6680A	13"	16mm	2500

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	urce Avalanche Ratings (Note	1)			,	
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	V _{DD} = 15 V, I _D = 56 A			200	mJ
I_{AR}	Maximum Drain-Source Avalanche (Current			56	Α
Off Chara	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	I _D =250μA,Referenced to 25°C		23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μА
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$.4	1.5	3	V
ΔV _{GS(th)} ΔT _J	Gate Threshold Voltage Temperature Coefficient	I _D =250μA,Referenced to 25°C	: //	-4		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 14 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 14 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 12 \text{ A}$	CX	0.008 0.012 0.010	0.0095 0.0160 0.0130	Ω
I _{D(on)}	On-State Drain Current	$V_{GS} = 5 \text{ V}, V_{DS} = 5 \text{ V}$	50			Α
g FS	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 14 \text{ A}$		41		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$		2180		pF
Coss	Output Capacitance	f = 1.0 MHz		500		pF
C _{rss}	Reverse Transfer Capacitance			255		pF
Switchine	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$		13	24	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		14	26	ns
t _{d(off)}	Turn-Off Delay Time	7		43	70	ns
t _f	Turn-Off Fall Time	7		15	27	ns
Q _g	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_{D} = 14 \text{ A},$		23	33	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 5 V$,		7		nC
Q_{gd}	Gate-Drain Charge			11		nC
Drain-So	urce Diode Characteristics a	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				2.3	Α
V _{SD}	Drain-Source Diode Forward	V _{GS} = 0 V, I _S = 2.3 A (Note 2)		0.72	1.2	V

Notes:

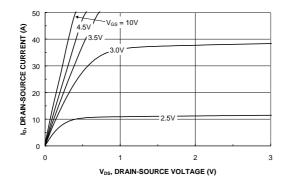
1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the drain tab. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width $\leq 300~\mu s,~Duty~Cycle \leq 2.0\%$

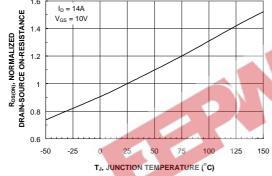
Typical Characteristics



2.2 V_{GS} = 3.0V 0.8 0 10 20 I_D, DRAIN CURRENT (A)

Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage. 0.03



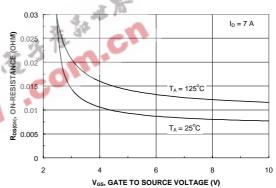
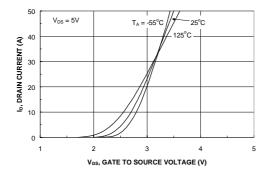


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



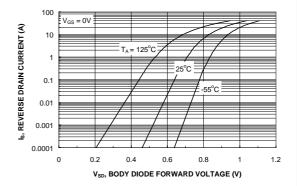
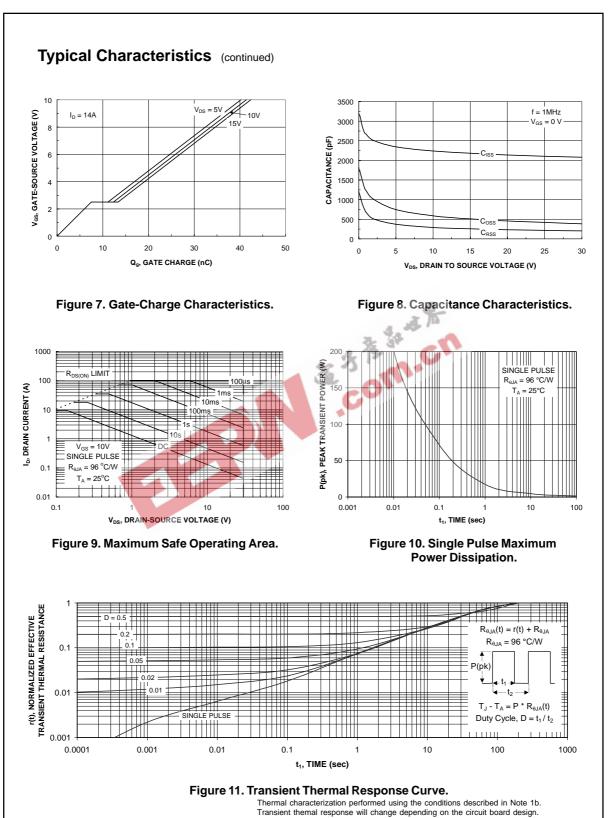
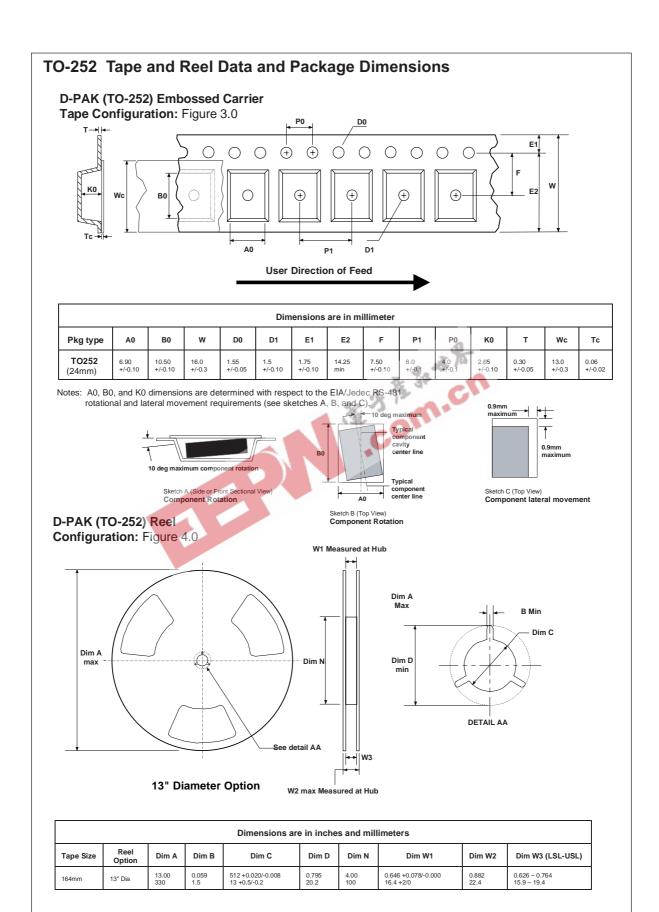


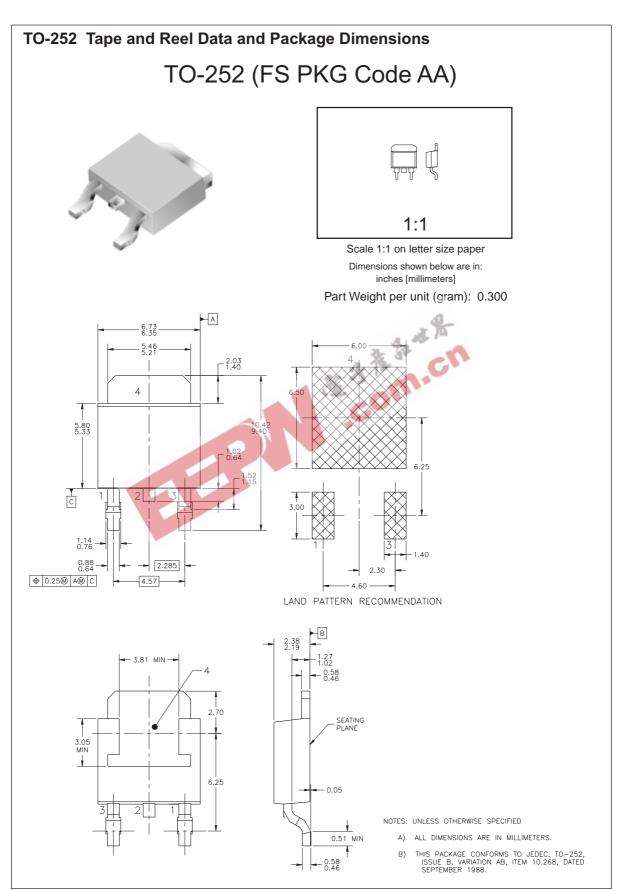
Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage **Variation with Source Current** and Temperature.









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